



DMC4050SSD

**D2** 

#### 40V COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

### **Product Summary**

			I <sub>D</sub> Max		
Device	V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> Max	$T_A = +25^{\circ}C$		
			(Notes 6 & 8)		
Q1	40V	45mΩ @ V <sub>GS</sub> = 10V	5.5A		
Qi	40 V	60mΩ @ V <sub>GS</sub> = 4.5V	4.2A		
Q2	-40V	45mΩ @ V <sub>GS</sub> = -10V	-5.8A		
	-40 V	60mΩ @ V <sub>GS</sub> = -4.5V	-4.2A		

#### **Description and Applications**

This MOSFET is designed to ensure that  $R_{DS(ON)}$  of N and P channel FET are matched to minimize losses in both arms of the bridge. The DMC4040SSD is optimized for use in 3-phase brushless DC motor circuits (BLDC), and CCFL backlighting.

- 3-Phase BLDC Motor
- CCFL Backlighting

### **Features and Benefits**

- Matched N & P R<sub>DS(ON)</sub> Minimizes Power Losses
- Fast Switching Minimizes Switching Losses
- Dual Device Reduces PCB Area
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- For automotive applications requiring specific change control (i.e.: parts qualified to AEC-Q100/101/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please refer to the related automotive grade (Q-suffix) part. A listing can be found at
  - https://www.diodes.com/products/automotive/automotive-products/.
- This part is qualified to JEDEC standards (as referenced in AEC-Q) for High Reliability.
  - https://www.diodes.com/quality/product-definitions/
- An Automotive-Compliant Part is Available Under Separate Datasheet (<u>DMC4055SSDQ</u>)

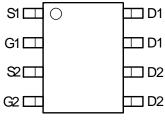
#### **Mechanical Data**

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound.
  UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin Annealed over Copper Leadframe.
  Solderable per MIL-STD-202, Method 208 (§3)
- Weight: 0.074 grams (Approximate)

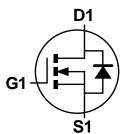
**SO-8** 



Top View



Top View



Equivalent Circuit

G<sub>2</sub>

### Ordering Information (Note 4)

Product	Case	Packaging
DMC4050SSD-13	SO-8	2500/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- For packaging details, go to our website at http://www.diodes.com/products/packages.html.



### **Marking Information**



Oll = Manufacturer's Marking C4050SD = Product Type Marking Code YYWW = Date Code Marking YY or YY = Year (ex: 20 = 2020) WW = Week (01 - 53)

## **Maximum Ratings** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic			Symbol	N-Channel - Q1	P-Channel - Q2	Units
Drain-Source Voltage	Drain-Source Voltage			40	-40	V
Gate-Source Voltage	Gate-Source Voltage			±20	±20	l v
		(Notes 6 & 8)		5.8	-5.8	
Continuous Drain Current	V <sub>GS</sub> = 10V	T <sub>A</sub> = +70°C (Notes 6 & 8)	I <sub>D</sub>	4.38	-4.52	A
		(Notes 5 & 8)		4.2	-4.2	
		(Notes 5 & 9)		5.3	-5.3	
Pulsed Drain Current	$V_{GS} = 10V$	(Notes 7 & 8)	I <sub>DM</sub>	24.1	-24.9	
Continuous Source Current (Body Diode)		(Notes 6 & 8)	Is	2.5	-2.5	
Pulsed Source Current (Body Diode) (Notes 7 & 8)		I <sub>SM</sub>	24.1	-24.9		

#### **Thermal Characteristics**

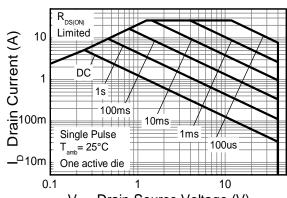
Characteristic	Symbol	Value	Unit		
Power Dissipation	(Notes 5 & 8)		1.25	W mW/°C	
Linear Derating Factor	(Notes 5 & 9)	PD	1.8		
	(Notes 6 & 8)		2.14	mivv/ C	
	(Notes 5 & 8)		100	1	
Thermal Resistance, Junction to Ambient	(Notes 5 & 9)	R <sub>0JA</sub>	70	00.44	
	(Notes 6 & 8)		58	°C/W	
Thermal Resistance, Junction to Lead	(Notes 5 & 10)	$R_{\theta JL}$	51		
Operating and Storage Temperature Range	T <sub>J,</sub> T <sub>STG</sub>	-55 to +150	°C		

Notes:

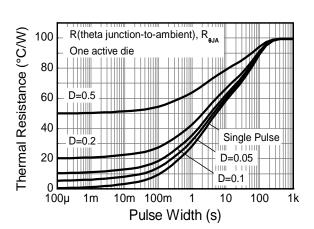
- 5. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
- 6. Same as note (5), except the device is measured at  $t \le 10$  sec.
- 7. Same as note (5), except the device is pulsed with D = 0.02 and pulse width  $300\mu s$ .
- 8. For a dual device with one active die.
- 9. For a device with two active die running at equal power.
- 10. Thermal resistance from junction to solder-point (at the end of the drain lead).



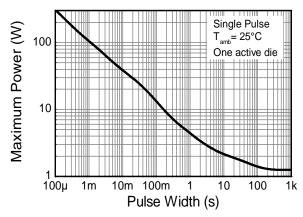
#### Thermal Characteristics (continued)



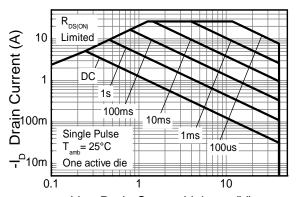
 $V_{\rm DS}$  Drain-Source Voltage (V) N-channel Safe Operating Area



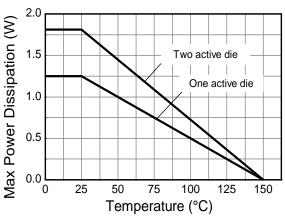
**Transient Thermal Impedance** 



**Pulse Power Dissipation** 



-V<sub>DS</sub> Drain-Source Voltage (V) **P-channel Safe Operating Area** 



**Derating Curve** 



## Electrical Characteristics (Q1 N-Channel) (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 11)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	40	_		V	$V_{GS} = 0V$ , $I_D = 250\mu A$	
Zero Gate Voltage Drain Current T <sub>J</sub> = +25°C	I <sub>DSS</sub>	_	_	1.0	μΑ	$V_{DS} = 40V$ , $V_{GS} = 0V$	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 11)							
Gate Threshold Voltage	V <sub>GS(th)</sub>	8.0	1.3	1.8	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$	
Static Drain-Source On-Resistance	D-s/s/n		20	45	mΩ	$V_{GS} = 10V$ , $I_D = 3A$	
Static Drain-Source Off-Nesistance	R <sub>DS(ON)</sub>		33	60	11122	$V_{GS} = 4.5V, I_D = 3A$	
Forward Transfer Admittance	Y <sub>fs</sub>	_	12.6		S	$V_{DS} = 5V, I_{D} = 3A$	
Diode Forward Voltage (Note 11)	$V_{SD}$	_	0.7	1.0	V	$V_{GS} = 0V, I_{S} = 1A$	
DYNAMIC CHARACTERISTICS (Note 12)							
Input Capacitance	C <sub>iss</sub>	_	1790.8		pF	.,	
Output Capacitance	Coss	_	160.6		pF	$V_{DS} = 20V, V_{GS} = 0V,$ f = 1.0MHz	
Reverse Transfer Capacitance	$C_{rss}$	_	120.5		pF	71 = 1.0MHZ	
Gate Resistance	$R_g$	_	1.03		Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$	
Total Gate Charge	Qg	_	37.56		nC	V 40V V 20V	
Gate-Source Charge	$Q_{gs}$	_	7.8		nC	$V_{GS} = 10V, V_{DS} = 20V,$ $I_{D} = 3A$	
Gate-Drain Charge	$Q_{gd}$	_	6.6	_	nC	ID = 3A	
Turn-On Delay Time	t <sub>D(on)</sub>	_	8.08		nS		
Turn-On Rise Time	t <sub>r</sub>	_	15.14		nS	$V_{GS} = 10V, V_{DS} = 20V,$	
Turn-Off Delay Time	t <sub>D(off)</sub>	_	24.29		nS	$I_D = 3A$	
Turn-Off Fall Time	t <sub>f</sub>	_	5.27	_	nS		

# Electrical Characteristics (Q2 P-Channel) (@T<sub>A</sub> = +25°C, unless otherwise specified.)

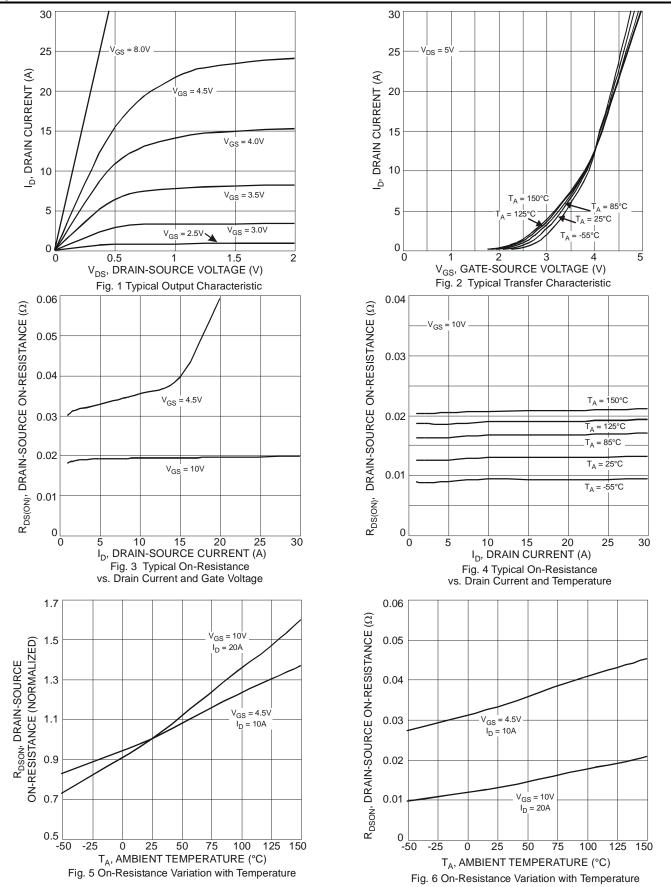
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 11)				I.			
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-40	_	_	V	$V_{GS} = 0V, I_D = -250\mu A$	
Zero Gate Voltage Drain Current T <sub>J</sub> = +25°C	I <sub>DSS</sub>	1	_	-1.0	μΑ	$V_{DS} = -40V, V_{GS} = 0V$	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 11)							
Gate Threshold Voltage	V <sub>GS(th)</sub>	-0.8	-1.3	-1.8	٧	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
Static Drain-Source On-Resistance			28	45 60	mΩ	$V_{GS} = -10V, I_D = -3A$	
Static Dialii-Source Oil-Resistance	R <sub>DS(ON)</sub>		30			$V_{GS} = -4.5V, I_{D} = -3A$	
Forward Transfer Admittance	Y <sub>fs</sub>	1	16.6	_	S	$V_{DS} = -5V, I_{D} = -3A$	
Diode Forward Voltage (Note 11)	$V_{SD}$	1	-0.7	-1.0	V	$V_{GS} = 0V, I_{S} = -1A$	
DYNAMIC CHARACTERISTICS (Note 12)							
Input Capacitance	C <sub>iss</sub>	1	1643.17		рF	N 00 V N 0 V	
Output Capacitance	C <sub>oss</sub>	l	179.13	l	рF	$V_{DS} = -20V, V_{GS} = 0V,$ - f = 1.0MHz	
Reverse Transfer Capacitance	C <sub>rss</sub>	1	127.82	-	pF	1 = 1.0WHZ	
Gate Resistance	Rg	1	6.43	_	Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$	
Total Gate Charge	Qg	1	33.66	-	nC	10)/ )/ 20)/	
Gate-Source Charge	Q <sub>gs</sub>	_	5.54	_	nC	$V_{GS} = -10V, V_{DS} = -20V,$	
Gate-Drain Charge	Q <sub>gd</sub>		7.30	_	nC	$I_D = -3A$	
Turn-On Delay Time	t <sub>D(on)</sub>	_	6.85	_	nS		
Turn-On Rise Time	t <sub>r</sub>		14.72	_	nS	$V_{GS} = -10V, V_{DS} = -20V,$	
Turn-Off Delay Time	t <sub>D(off)</sub>	_	53.65	_	nS	$I_D = -3A$	
Turn-Off Fall Time	t <sub>f</sub>	_	30.86	_	nS	7	

Notes:

- 11. Short duration pulse test used to minimize self-heating effect.12. Guaranteed by design. Not subject to production testing.



### Typical Characteristics (Q1 N-Channel)







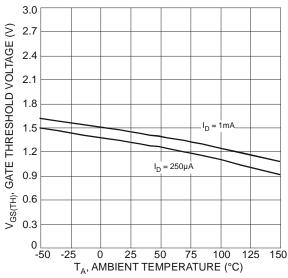
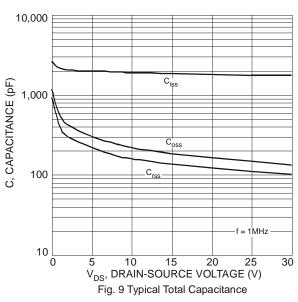
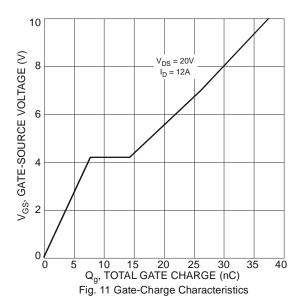
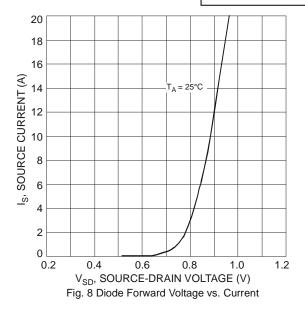
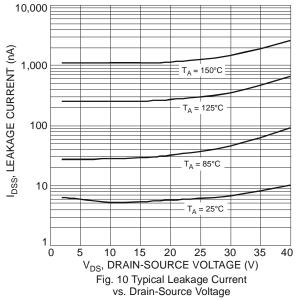


Fig. 7 Gate Threshold Variation vs. Ambient Temperature











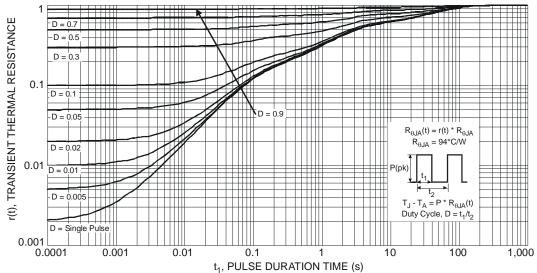
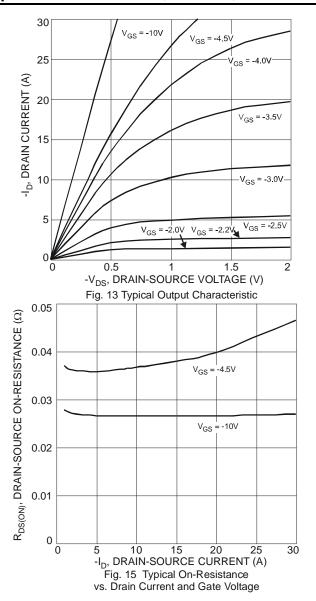
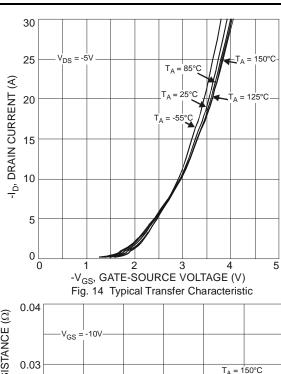


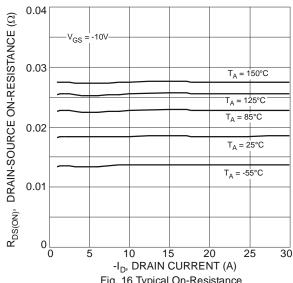
Fig. 12 Transient Thermal Response

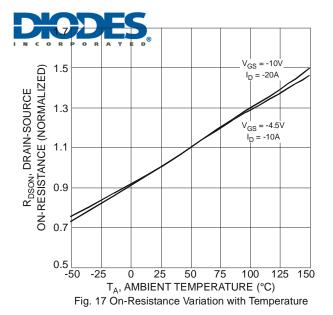


## Typical Characteristics (Q2 P-Channel)



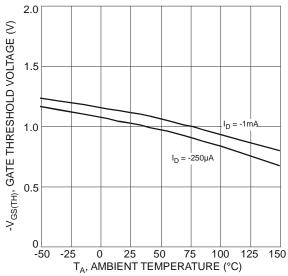


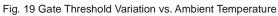


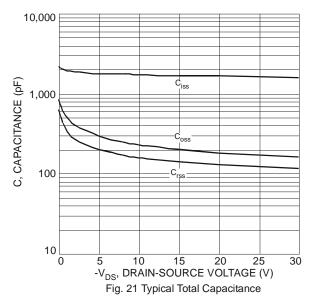


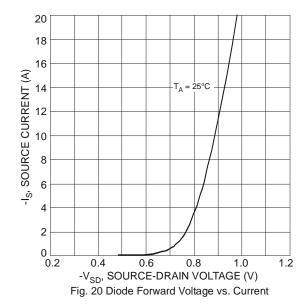
0.06 **DMC4050SSD**  $R_{DSON}$ , DRAIN-SOURCE ON-RESISTANCE  $(\Omega)$ 0.05 0.04 0.03 .V<sub>GS</sub> : I<sub>D</sub> = -10A 0.02  $V_{GS}^{'} = -10^{1}$ V I<sub>D</sub> = -20A 0.01 -50 25 50 75 100 125 150 T<sub>A</sub>, AMBIENT TEMPERATURE (°C)

Fig. 18 On-Resistance Variation with Temperature

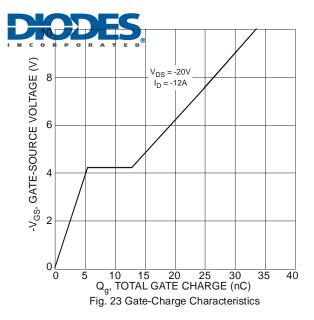


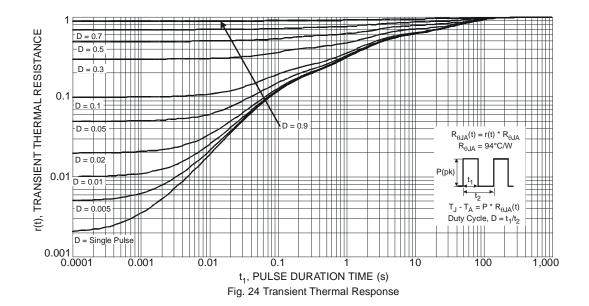






10,000 -I<sub>DSS</sub>, LEAKAGE CURRENT (nA) T<sub>A</sub> = 150°C 1,000  $T_A = 125^{\circ}C$ 100  $T_A = 85^{\circ}C$ 10 T<sub>A</sub> = 25°C 20 25 30 40 15 -V<sub>DS</sub>, DRAIN-SOURCE VOLTAGE (V) Fig. 22 Typical Leakage Current vs. Drain-Source Voltage

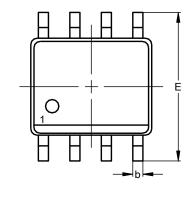


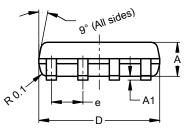


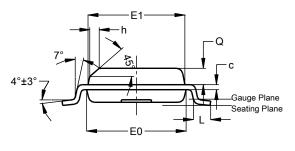


### **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.







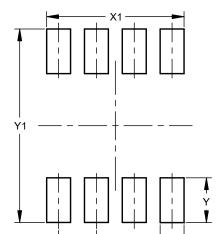
**SO-8** 

**SO-8** 

SO-8						
Dim	Min Max Ty					
Α	1.40	1.50	1.45			
A1	0.10	0.20	0.15			
b	0.30	0.50	0.40			
С	0.15	0.25	0.20			
D	4.85 4.95 4.9		4.90			
Е	5.90	6.10	6.00			
E1	3.80	3.90	3.85			
E0	<b>E0</b> 3.85 3.95 3.90		3.90			
е	e 1.27					
h	-		0.35			
L	0.62	0.82	0.72			
Q	0.60	0.70	0.65			
All Dimensions in mm						

### **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.



Dimensions	Value (in mm)
С	1.27
Х	0.802
X1	4.612
Y	1.505
Y1	6.50



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